



**/ Absolute Maximum Ratings(Ta=25 )**

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	700	V
Gate-Source Voltage	$V_{GS}$	±30	V
Drain Current	$I_D(T_c=25 )$	4.0	A
Drain Current	$I_D(T_c=100 )$	2.5	A
Drain Current - Pulsed	$I_{DM}$	16	A
Single Pulsed Avalanche Energy	$E_{AS}$	260	mJ
Power Dissipation	$P_{tot}$	36	W
Junction Temperature Range	$T_j$	150	
Storage Temperature Range	$T_{stg}$	-55~150	
Junction-to-Case	$R_{JC}$	3.47	/W
Junction-to-Ambient	$R_{JA}$	62.5	/W

**/ Electrical Characteristics(Ta=25 )**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V$ $I_D=250\mu A$	700			V
Breakdown Voltage Temperature Coefficient	$BV_{DSS} / T_j$	$I_D=250\mu A$ Referenced to 25		0.65		V/
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}$ $I_D=250\mu A$	2.0		4.0	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=700V$ $V_{GS}=0V$ $T_j=25$			1	$\mu A$
		$V_{DS}=560V$ $V_{GS}=0V$ $T_j=125$			10	$\mu A$
Forward Transconductance	$g_{FS}$	$V_{DS}=40V$ $I_D=2.0A$		4.0		S
Gate-Body Leakage Current Forward	$I_{GSS}$	$V_{GS}=\pm 30V$			±100	nA
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=10V$ $I_D=2.0A$		1.93	2.2	
Input Capacitance	$C_{iss}$	$V_{GS}=0V$ $V_{DS}=25V$ $V_F=1.0MHz$		520		pF
Turn-Off Delay Time	$t_{d(off)}$	$V_{DD}=350V$ $I_D=4.0A$ $R_G=25$		25		ns

**/ Electrical Characteristics(Ta=25 )**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Total Gate Charge	$Q_g$	$I_D=4.0A$ $V_{DS}=560V$ $V_{GS}=10V$		17.4		nC
Gate-to-Source Charge	$Q_{gs}$			4.8		nC
Gate-to-Drain Charge	$Q_{gd}$			5.4		nC
Continuous Diode Forward Current	$I_S$				4.0	A
Diode Forward Voltage	$V_{SD}$	$I_S=4.0A$ $V_{GS}=0V$ $T_j=25$			1.4	V
Reverse Recovery Time	$t_{rr}$	$I_f=4.0A$ $T_j=25$ $di/dt=100A/\mu s$		250		nS
Reverse Recovery Charge	$Q_{rr}$			1.5		uC

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Repetitive rating: Pulse width limited by maximum junction temperature

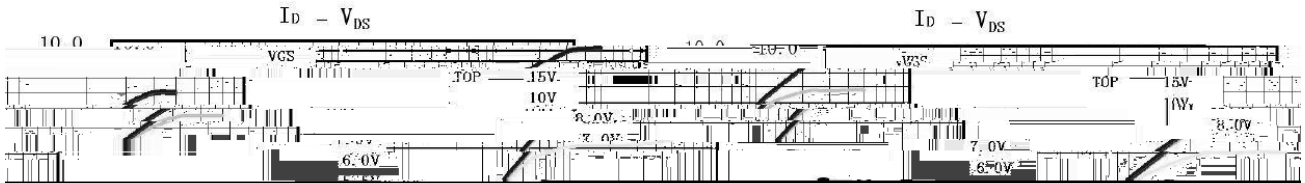
4), #M; 4, 'M4\*' d ? # > 4), #8,4 +%8

Starting  $T_j=25$  ,  $V_{DD}=50V$ ,  $L=30mH$ ,  $R_G=25$  ,  $I_{AS}=4.0A$

\*' ' j )

Pulse Test:Pulse width 300μs,Duty cycle 2%

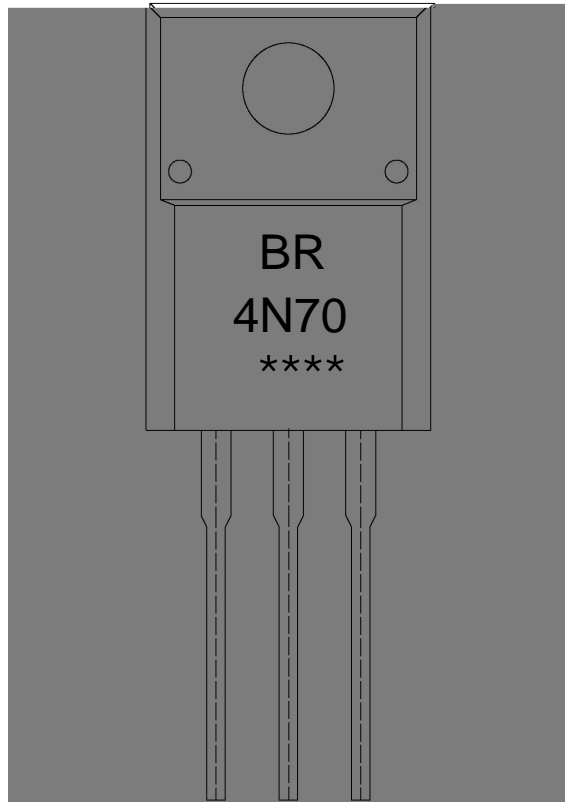
/ **Electrical Characteristic Curve**



/ Package Dimensions



**/ Marking Instructions**



BR

4N70

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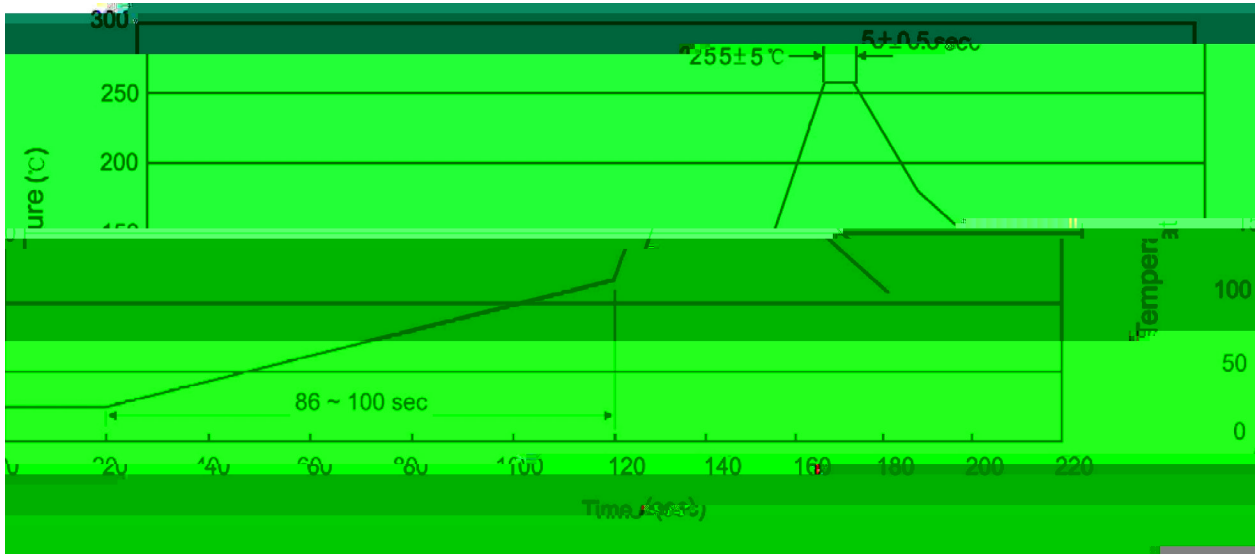
Note:

BR: Company Code

4N70: Product Type.

\*\*\*\*: Lot No. Code, code change with Lot No.

( ) / Temperature Profile for Dip Soldering(Pb-Free)



Note:

- |   |        |     |            |          |   |
|---|--------|-----|------------|----------|---|
| 1 | 25     | 150 | 60         | 90sec;   | 1.Preheating:25~150 , Time:60~90sec.      |
| 2 | 255..5 |     | 5..0.5sec; |          | 2.Peak Temp.:255..5 , Duration:5..0.5sec. |
| 3 |        |     | 2          | 10 /sec. | 3. Cooling Speed: 2~10 /sec.              |

/ Resistance to Soldering Heat Test Conditions

270..5                      10..1 sec.                      Temp.:270±5                      Time:10±1 sec

/ Packaging SPEC.

/ BULK

Package Type	Units					Dimension (unit mm <sup>3</sup> )		
	Units/Bag	Bags/Inner Box	Units/Inner Box	Inner Boxes/Outer Box	Units/Outer Box	Bag	Inner Box	Outer Box